

# **Dual N-Channel 30 V (D-S) MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}$ (m $\Omega$ )	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)		
30	23 at V <sub>GS</sub> = 10 V	4.5	26.50		
	36 at V <sub>GS</sub> = 4.5 V	4.5	3.6 nC		



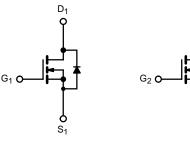
COMPLIANT

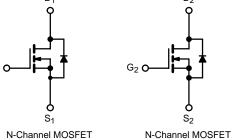
### **FEATURES**

- TrenchFET II Power MOSFET
- **PWM Optimized**
- Compliant to RoHS Directive 2002/95/EC

### **APPLICATIONS**

- Portable devices such as smart phones, tablet PCs and mobile computing
  - Load switch
  - DC/DC converter
  - Power management





DFN 2X	PIN1
	SI G1 D2
Top View	D1 G2 S2 Bottom View

<b>ABSOLUTE MAXIMUM RATINGS</b> T <sub>A</sub> = 25 °C, unless otherwise noted				
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V <sub>DS</sub>	30	V
Gate-Source Voltage		$V_{GS}$	± 20	
	T <sub>C</sub> = 25 °C		4.5 <sup>a</sup>	
Continuous Prain Current (T. – 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	3.3	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C		1.9 <sup>b, c</sup>	A
	T <sub>A</sub> = 70 °C		0.93 <sup>b, c</sup>	
Pulsed Drain Current		I <sub>DM</sub>	20	
	T <sub>C</sub> = 25 °C		4.5	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	1.7 <sup>b, c</sup>	
	T <sub>C</sub> = 25 °C		7.5	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	4.8	W
	T <sub>A</sub> = 25 °C	l LD	1.78 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		1.14 <sup>b, c</sup>	1
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 5 s	R <sub>thJA</sub>	50	65	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	12	16	<i>5/</i> <b>VV</b>

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 220 °C/W.





Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A		15		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu A$		4.6		mv/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V			± 100	nA	
Zava Cata Valtaga Dvaig Courset	I <sub>DSS</sub>	V <sub>DS</sub> =30 V, V <sub>GS</sub> = 0 V			1		
Zero Gate Voltage Drain Current		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 85 ^{\circ}\text{C}$			10	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	3			Α	
Drain-Source On-State Resistance <sup>a</sup>	D	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A		23	35		
Dialit-Source Off-State nesistance	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 3 \text{ A}$		36	58	mΩ	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 3 A		20		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			750			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		116		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			20			
Tatal Cata Chausa	Qg	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		6.6	12		
Total Gate Charge		V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 3 A		3.6	8	nC	
Gate-Source Charge	$Q_{gs}$			0.35			
Gate-Drain Charge	Q <sub>gd</sub>			0.29			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		8.5		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			12			
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_1 = 12 \Omega$		35			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		16		- ns	
Fall Time	t <sub>f</sub>			10			
Drain-Source Body Diode Characteristic	s				•	1	
Continuous Source-Drain Diode Current	Is	T <sub>C</sub> = 25 °C			4.5		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				20	Α	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	-		25	50	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			15	30	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		12			
Reverse Recovery Rise Time	t <sub>b</sub>			13		ns	

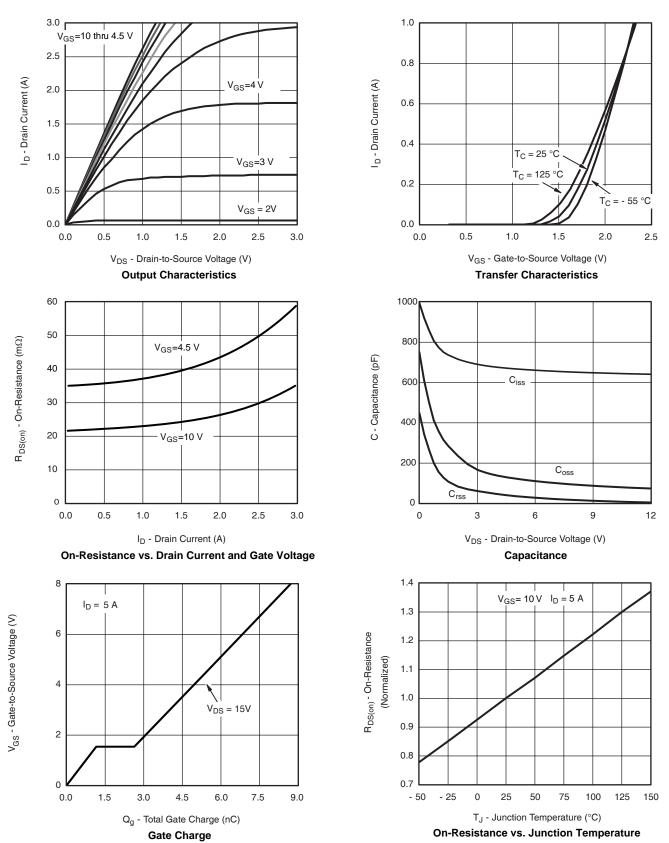
#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq$  300  $\mu s,\ duty\ cycle <math display="inline">\leq$  2 % b. Guaranteed by design, not subject to production testing.

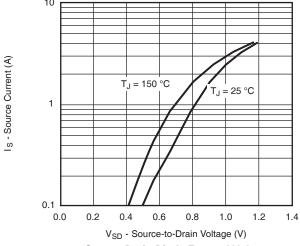


## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

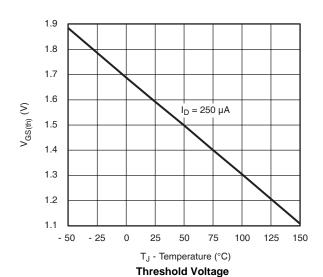




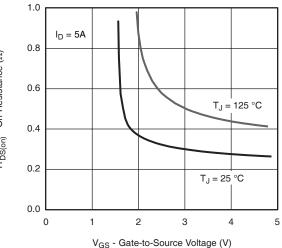
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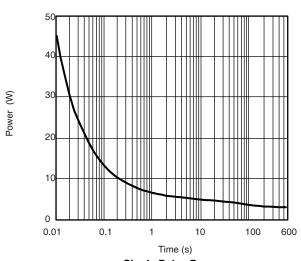
#### Source-Drain Diode Forward Voltage



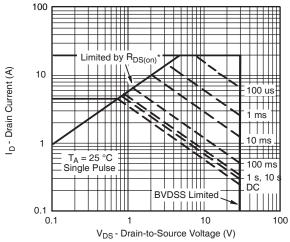
 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$  - On-Resistance  $(\Omega)$ 



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power

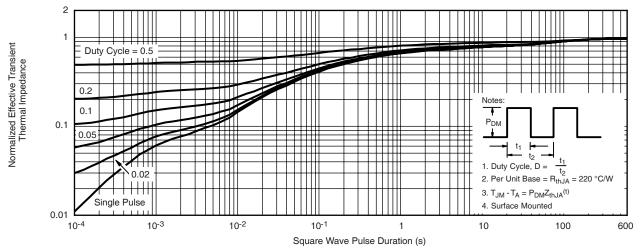


\*  $V_{GS} > \mbox{minimum } V_{GS}$  at which  $R_{DS(on)}$  is specified

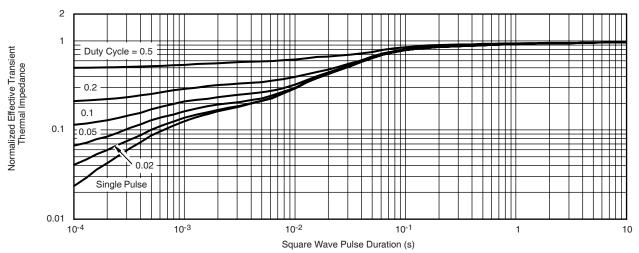
Safe Operating Area, Junction-to-Ambient



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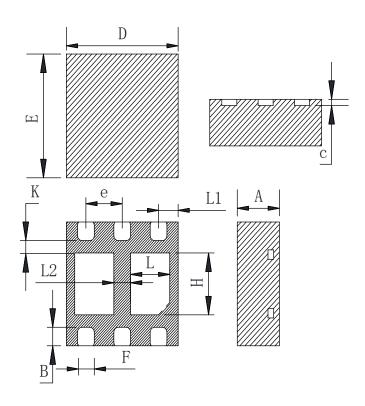
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



# **DFN 2X2-D PACKAGE OUTLINE**



Symbol	Min	Тур	Max
A	0.70	0.75	0.80
В	0.20	0.30	0.40
С	0.153	0.203	0.253
D	1.90	2.00	2.10
Е	1.90	2.00	2.10
e	0.55	0.65	0.70
F	0.20	0.30	0.40
Н	0.85	1.00	1.10
L	0.55	0.70	0.80
L1	0.25	0.35	0.45
L2	0.20	0.30	0.40
K	0.15	0.20	0.30





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